## Search Notes



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Applicant(s)/Patent Under Reexamination ZHANG ET AL.

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## SEARCHED

Class	Subclass	Date	Examiner			
709	227, 230 with keyword search	12/04/2007	RLP			
713	150-156, 168, 170 with keywork search	12/04/2007	RLP			

## SEARCH NOTES

Search Notes	Date	Examiner
EAST-USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT	12/04-07/2007	RLP
Inventor's Search	12/07/2007	RLP
EAST-USPGPUB, USPAT, EPO, JPO, DERWENT, IBM_TDB	06/10/2008	RLP

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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